



FQD7N10L / FQU7N10L

100V LOGIC N-Channel MOSFET

General Description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology is especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation modes. These devices are well suited for low voltage applications such as high efficiency switching DC/DC converters, and DC motor control.

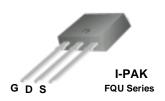
Features

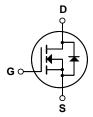
- 5.8A, 100V, $R_{DS(on)} = 0.35\Omega$ @ $V_{GS} = 10$ V
- Low gate charge (typical 4.6 nC)
- Low Crss (typical 12 pF)
- · Fast switching
- 100% avalanche tested
- · Improved dv/dt capability
- Low level gate drive requirments allowing direct operation from logic drives
- RoHS Compliant



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Absolute Maximum Ratings $T_C = 25$ °C unless otherwise noted

Symbol	Parameter		FQD7N10L / FQU7N10L	Units
V _{DSS}	Drain-Source Voltage		100	V
I _D	Drain Current - Continuous (T _C = 25°C)		5.8	Α
	- Continuous (T _C = 100°	C)	3.67	Α
I _{DM}	Drain Current - Pulsed	(Note 1)	23.2	Α
V _{GSS}	Gate-Source Voltage		± 20	V
E _{AS}	Single Pulsed Avalanche Energy (Note 2)		50	mJ
I _{AR}	Avalanche Current (Note 1)		5.8	Α
E _{AR}	Repetitive Avalanche Energy	(Note 1)	2.5	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	6.0	V/ns
P _D	Power Dissipation (T _A = 25°C) * Power Dissipation (T _C = 25°C) - Derate above 25°C		2.5	W
			25	W
			0.2	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +150	°C
T _L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C

Thermal Characteristics

Symbol	Parameter	Тур	Max	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case		5.0	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient *		50	°C/W
R _{θJA} Thermal Resistance, Junction-to-Ambient			110	°C/W

* When mounted on the minimum pad size recommended (PCB Mount)

Symbol	Parameter	Test Conditions	3	Min	Тур	Max	Units
Off Cha	aracteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		100			V
ΔBV _{DSS} / ΔT _J	Breakdown Voltage Temperature Coefficient	I _D = 250 μA, Referenced	l to 25°C		0.1		V/°C
I _{DSS}	Zero Octo Valta va Brain Octobra	V _{DS} = 100 V, V _{GS} = 0 V				1	μΑ
	Zero Gate Voltage Drain Current	V _{DS} = 80 V, T _C = 125°C				10	μΑ
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = 20 V, V _{DS} = 0 V				100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	V _{GS} = -20 V, V _{DS} = 0 V				-100	nA
On Cha	racteristics						
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$		1.0		2.0	V
R _{DS(on)}	Static Drain-Source $V_{GS} = 10 \text{ V}, I_D = 2.9 \text{ A}$				0.275	0.35	-
()	On-Resistance	$V_{GS} = 5 \text{ V}, I_D = 2.9 \text{ A}$			0.300	0.38	38 Ω
9 _{FS}	Forward Transconductance	$V_{DS} = 30 \text{ V}, I_{D} = 2.9 \text{ A}$	(Note 4)	-	4.6		S
C _{iss} C _{oss} C _{rss}	Input Capacitance Output Capacitance Reverse Transfer Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1.0 MHz			220 55 12	290 72 15	pF pF pF
	ing Characteristics						Ρ.
t _{d(on)}	Turn-On Delay Time	V 50.V.I 70.A			9	30	ns
t _r	Turn-On Rise Time	$V_{DD} = 50 \text{ V}, I_{D} = 7.3 \text{ A},$ $R_{G} = 25 \Omega$			100	210	ns
t _{d(off)}	Turn-Off Delay Time				17	45	ns
t _f	Turn-Off Fall Time		(Note 4, 5)		50	110	ns
Qg	Total Gate Charge	$V_{DS} = 80 \text{ V}, I_{D} = 7.3 \text{ A},$ $V_{GS} = 5 \text{ V}$ (Note 4, 5)			4.6	6.0	nC
Q _{gs}	Gate-Source Charge				1.0		nC
Q _{gd}	Gate-Drain Charge			-	2.6		nC
Drain-S	Source Diode Characteristics a	nd Maximum Rating	s				
I _S	Maximum Continuous Drain-Source Diode Forward Current					5.8	Α
I_{SM}	Maximum Pulsed Drain-Source Diode F	Forward Current				23.2	Α
V_{SD}	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_{S} = 5.8 \text{ A}$				1.5	V
+	Reverse Recovery Time	$V_{GS} = 0 \text{ V}, I_{S} = 7.3 \text{ A},$			70		ns
t _{rr} Q _{rr}	Trovordo Trocovery Time	, 00					

- Notes: Notes: 1. Repetitive Rating: Pulse width limited by maximum junction temperature 2. L = 2.23mH, I_{AS} = 5.8A, V_{DD} = 25V, R_{G} = 25 Ω , Starting T_{J} = 25°C 3. I_{SD} ≤ 7.3A, di/dt ≤ 300A/ μ_{B} , V_{DD} ≤ BV $_{DSS}$, Starting T_{J} = 25°C 4. Pulse Test: Pulse width ≤ 300 μ_{B} , Duty cycle ≤ 2% 5. Essentially independent of operating temperature

Typical Characteristics

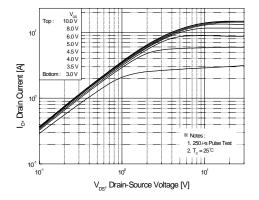


Figure 1. On-Region Characteristics

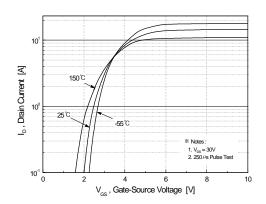


Figure 2. Transfer Characteristics

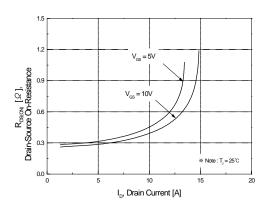


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

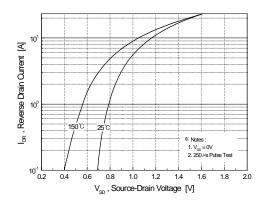


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

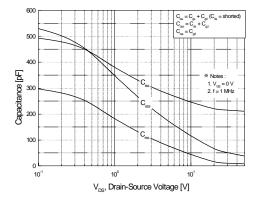


Figure 5. Capacitance Characteristics

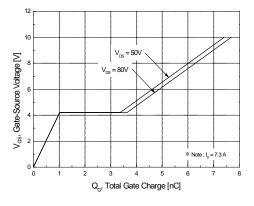
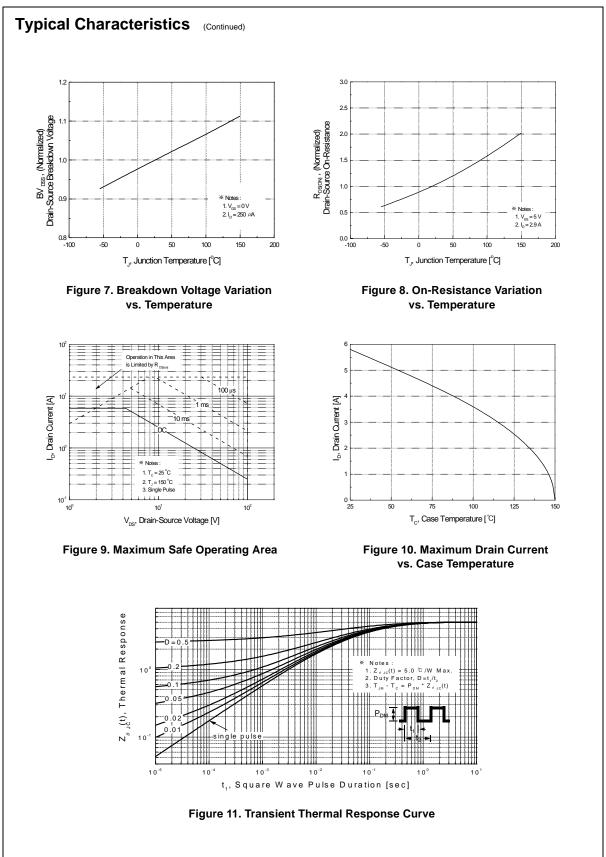


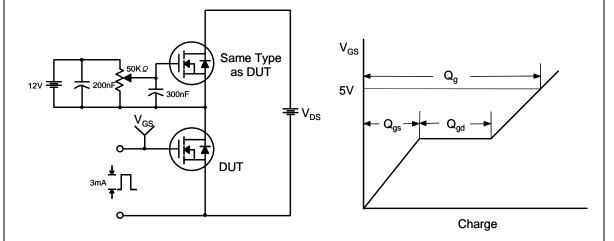
Figure 6. Gate Charge Characteristics

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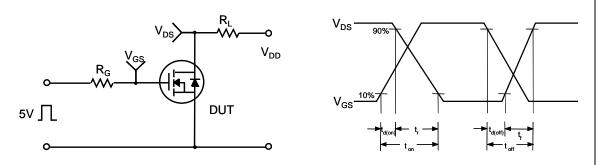


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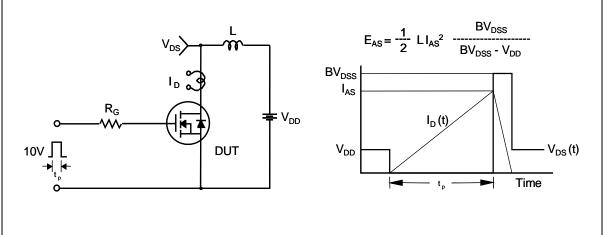
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms

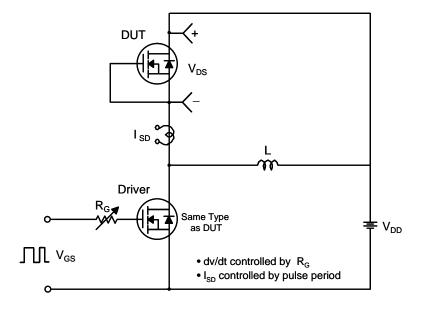


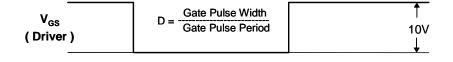
Unclamped Inductive Switching Test Circuit & Waveforms

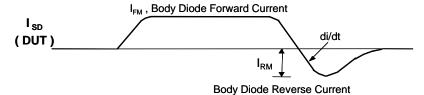


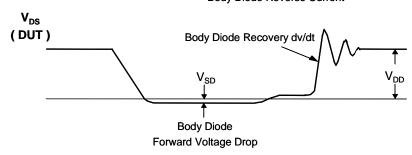
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Peak Diode Recovery dv/dt Test Circuit & Waveforms



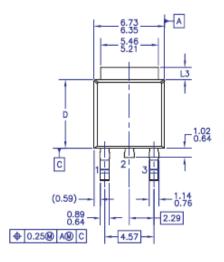


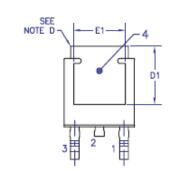


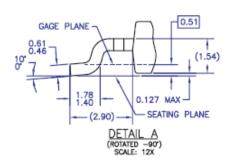


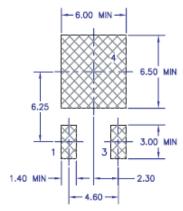
Mechanical Dimensions

D - PAK

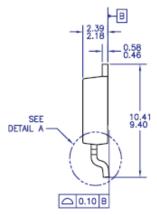




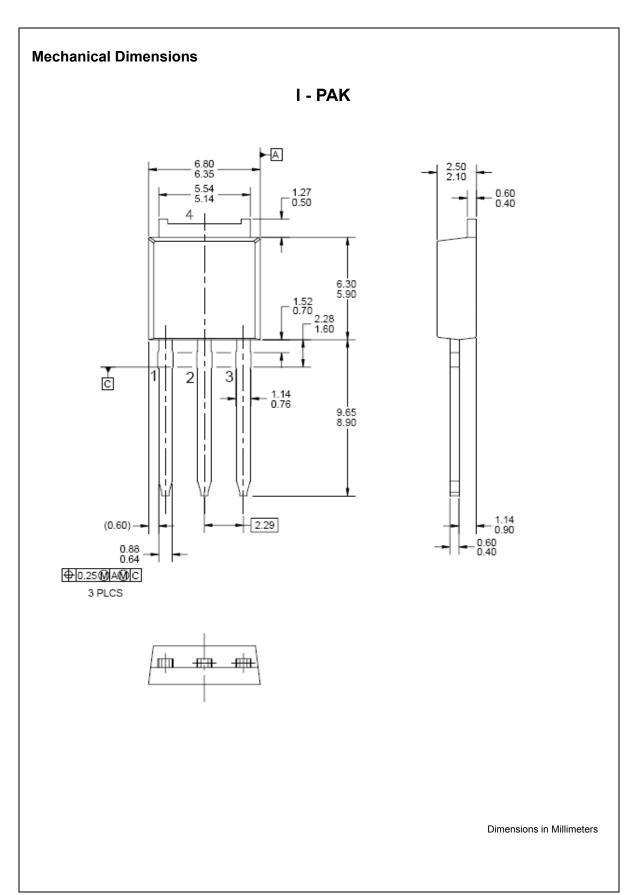




LAND PATTERN RECOMMENDATION



Dimensions in Millimeters







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